12 Rec'd PCT/PTO 0 7 JAN 2005 10/520815^{Sheet 1 of 1}

Form PTO-1449			ATTY DOCKET NO. 2691-000013/US		APPLICATION NO. NEW APPLICATION			
INF	FORMATION DISCLOSURE IN AN APPLICATION	APPLICANT(S) Kohshi TAGUCHI et al. FILING DATE January 7, 2005		CONF. NO. Unknown GROUP Unknown				
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	U	.S. PATENT DO	OCUMENTS					
EXAMINER INITIAL	DOCUMENT NUMBER DATE		NAME CLASS		SUB CLASS		FILING DATE IF APPROPRIATE	
	FOR	 EIGN PATENT	DOCUMENTS					
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	<u> </u>	SLATION	
Han	JP 5-263255 A	10/12/1993	JAPAN			YES	NO	
HEA	EP 300447 A2	10/05/2001	EUROPE	- 				
HEA	JP 9-41147 A	. 02/10/1997	JAPAN					
								
				 				
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OTHER page(s), volume-iss	DOCUMENTS (lactude Name of the author (i se number(s), publisher, city and/or country where published.	n CAPITAL LETTERS), title of th	e article (when appropriate), title of the item (book, mugazine, j	ournal, serial, syr	mpostum, catal	log, etc.) date,	
								
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Sheet I of I

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2691-000013/US	10/520,815	
APPLICANTS		
Kohshi TAGUCHI et al.	•	
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January 7, 2005	Unknown	

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Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date		
	HEA	US 5,508,067	04/16/1996	Tatsuya SATO et al.				
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